Cancel all claims of record and substitute amended claim 1-5, 10-26; withdrawn claim 7; original claim 9; and new claim 27, as follows:

- 1 1. (currently amended): Apparatus for the collection and focusing of gas-phase ions and/or or particles at or near atmospheric pressure, the apparatus comprising:
- a. a dispersive source of ions;
  - b. a conductive high transmission surface populated with a plurality of holes through which <u>said</u> ions pass unobstructed on the way to a collector target, aperture, or tube; <u>said high transmission</u> <u>surface having a topside and an underside</u>, the said <u>high transmission</u> surface being supplied with an attracting electric potential by connection to a voltage supply, and generating an electrostatic field between the <u>said</u> source of ions and the top side <u>said</u> topside of the <u>said high</u> <u>transmission</u> surface; the said <u>high transmission</u> surface also being shaped to affect high focusing fields on the focusing side, <u>underside</u>, of the <u>said high transmission</u> surface, <u>whereby said electrostatic field at said underside of said high transmission surface is greater than said electrostatic field at said topside of said high transmission surface;</u>
  - c. a target surface for receiving ions or transmitting focused ions through opening of target apertures, or tubes aperture, or tube in said target surface; said target surface held at a second ion-attracting and higher strength electric potential by connection to the said voltage supply, and generating an electrostatic field between the said underside of said high transmission surface and the orifice said opening of said target aperture or tube which has electrostatic field lines that are concentrated on a relatively small reduced cross-sectional area of said target surface, said opening of said target aperture, or opening of said tube opening;
  - d. an inner field-shaping electrode for focusing ions exiting the underside of said <u>high</u>

    <u>transmission</u> surface whereby approximately all <u>said</u> ions are focused toward <u>said</u> small reduced cross-sectional area on the said target surface.
    - 2. (currently amended): Apparatus as in claim 1 wherein the <u>said</u> target surface comprises a conductive end of a capillary tube, wherein said capillary tube is the atmospheric or near



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- 3. (currently amended): The apparatus of claim 1 wherein said inner field-shaping electrode is a metal electrode whereby said electric electrostatic potential from said target surface penetrates into the a focusing region between the backside underside of said high transmission surface and said metal electrode through a single central aperture in said metal electrode.
- 4. (currently amended): The apparatus of claim 1 wherein said inner field-shaping electrode is a metal electrode held at the same potential as the said high transmission surface.
- 5. (currently amended): The apparatus as in claim 1 further including an analytical apparatus in communication with the <u>said</u> target <u>surface</u> aperture or tube <u>in said target surface</u>, wherein the <u>said</u> aperture <u>or tube</u> is interposed between the underside of said <u>target high</u> <u>transmission</u> surface and the <u>said</u> analytical apparatus, said <u>small reduced</u> cross-sectional area of ions being directed through the <u>said opening of said target</u> aperture <u>or tube</u> into said analytical apparatus.
  - 6. (currently amended): Apparatus as in claim 5 wherein said analytical apparatus comprises a mass spectrometer or ion mobility spectrometer or combination thereof.
  - 7. (withdrawn): Apparatus as in claim 5 wherein said analytical apparatus comprises an ion mobility spectrometer.
- 8. (currently amended): Apparatus as in claim 1 wherein said gas-phase ions are formed by means of an atmospheric or near atmospheric ionization sources such as, electrospray, atmospheric pressure chemical ionization, atmospheric laser desorption, photoionization, discharge ionization, inductively coupled plasma ionization. electrospray, atmospheric pressure chemical ionization, laser desorption, photoionization, or discharge ionization sources; or inductively coupled plasma ionization source, or a combination thereof.
  - 9. (original): Apparatus of claim 8 wherein said atmospheric or near atmospheric ionization source is made up of a plurality of said atmospheric or near atmospheric ion sources operated simultaneously or sequentially.

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a. a source of charged droplets or particles;

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b. a conductive high transmission surface with a plurality of holes through which said aerosol of charged droplets pass unobstructed on the way to a target surface, said high transmission surface having a topside and an underside, the said high transmission surface being supplied with an attracting electric electrostatic potential by connection to a voltage supply, and generating an electrostatic field between the said source of charged droplets, from an said

- 10. (currently amended): Apparatus of claim 1, wherein said target surface, is made up of a plurality of said focal points resulting from mechanical variation variations of said inner field-shaping electrode electrode's position and shape. Ions and shape, ions or charged particles collected at the said focal points, being accumulated onto the said target surface for collection or passed through said opening in said target apertures aperture and or tubes tube for analysis.
- 11. (currently amended): Apparatus in claim 1 further including a pure gas supplied in such a way between the said target surface and said inner field-shaping electrode, or between the said inner field-shaping electrode and the said high transmission surface, whereby substantially all said gas flows into the said focusing region between said inner field shaping electrode and said high-transmission surface and through the said plurality of holes in said high transmission surface.
- 12. (currently amended): An apparatus in claim 1 further including an outer field-shaping electrode surrounding the circumference of the <u>said</u> high transmission surface; said outer field-shaping electrode held at a potential the same or slightly above the potential on the <u>said</u> high transmission surface, said outer field-shaping electrode functioning to shield the <u>outer surface</u> topside of the <u>said</u> high transmission surface from high <u>electrostatic</u> fields found in some needle containing source regions that suppress <u>said electrostatic</u> field penetration from the <u>said</u> focusing region <u>potentials</u> into the <u>said ion</u> source region.
- 13. (currently amended): Apparatus for the collection and focusing of an aerosol of gas-phase charged particles or droplets or particles at or near atmospheric pressure, the apparatus comprising:

ionization; or combination thereof.

atmospheric ionization source, and the top side said topside of said high transmission surface, whereby said electrostatic field at said underside of said high transmission surface is greater than said electrostatic field at said topside of said high transmission surface;

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c. a target surface for receiving droplets said charged particles, the said target surface being supplied with a second ion-attracting and higher strength electrical electrostatic potential by connection to the said voltage supply, and generating an electrostatic field between the said underside of said high transmission surface and the target said target surface whereby electric electrostatic field lines are concentrated to a small reduced cross-sectional area on the said target surface:

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d. an inner field-shaping electrode for focusing said charged particles exiting the said underside of said high transmission surface whereby approximately all said charged droplets are focused onto said target surface.

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14. (currently amended): The apparatus of claim 13 wherein said inner field-shaping electrode is a metal electrode whereby said electric electrostatic field from said target surface penetrates into a focusing region between the backside said underside of said high transmission surface and said inner field-shaping electrode through a central aperture in the said inner fieldshaping electrode.

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15. (currently amended): The apparatus of claim 13 wherein the said charged droplets and or particles are formed by means of atmospheric or near atmospheric pressure ionization hsources, such as, electrospray, discharge ionization, electron capture ionization, and inductive eharging.; electrospray, atmospheric inductive charging, discharge, or electron capture

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> 16. (currently amended): The apparatus of claim 15 wherein the said atmospheric or near atmospheric ionization source is made up of a plurality of sources.

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17. (currently amended): The apparatus of claim 13 wherein the said target surface is made up of a plurality of targets whereby position and time dependence of focal points of said electrostatic field lines are determined by variation in the geometry, position, and potential of

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- 18. (currently amended): A Method for the transfer of charged particles and/or or ions from a highly 1 dispersive area or source at or near atmospheric pressure and focusing approximately all said 2 charged particles and or ions into an inlet aperture for gas-phase ion analysis, the method 3 comprising: 4
  - a. providing electrical electrostatic attraction to ions and said charged particles or ions with electrostatic fields provided by a perforated high transmission surface, the said perforated high transmission surface having an ion drawing potential, such that electrostatic field lines between the said source of gas-phase ions or charged particles or ions particle and said perforated high transmission surface are concentrated on the topside top side of said perforated high transmission surface;
  - b. transmitting said charged particles or ions through said perforated high transmission surface by allowing the unobstructed passage into a focusing region by providing a plurality of holes in said perforated high transmission surface with low depth aspect ratio, a high openness aspect ratio, and a high electrical electrostatic potential ratio greater than one, between the backside underside and said topside of said perforated high transmission surface and a target surface, and;
    - c. providing electrostatic attraction to said charged particles or ions in the said focusing region with a second electrostatic field generated by said a target surface, the said target surface having an ion-drawing potential such that electrostatic field lines between the backside said underside of said perforated high transmission surface and said inlet aperture in said target surface are concentrated onto the said target surface urging approximately all ions or said charged particles or ions in said focusing region to be directed towards said target surface whereby approximately all ions and said charged particles or ions flow into said inlet aperture as a small reduced cross-sectional area.
    - 19. (currently amended): Method as in claim 18, wherein providing the transfer of said charged particles or ions from said highly dispersive sources source at or near atmospheric pressure for gas-phase ion analysis, comprises said inlet aperture at the a focal point of the focal region

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23. (currently amended): Method as in claim 18, wherein providing the transfer of <u>said</u> charged particles <u>or ions</u> from <u>said</u> dispersive <u>sources</u> <u>source</u> at <u>or near atmospheric pressure</u> for gasphase ion analysis, <u>eomprises an</u> <u>said inlet aperture is</u> an inlet <del>aperture</del> of an ion mobility spectrometer.

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24. (currently amended): Method as in claim 18, wherein providing the transfer of <u>said</u> charged particles <u>or ions</u> from <u>said</u> dispersive <u>sources</u> source at or near atmospheric <u>pressure</u> for gasphase ion analysis, comprises a plurality of dispersive sources of said <del>ions or charged</del> <u>particles charged particles or ions</u>.

25. (currently amended): Method as in claim 18, wherein providing the transfer of said charged particles or ions from said highly dispersive source at or near atmospheric pressure for gas-

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- 26. (currently amended): Method as in claim 18 further comprising feeding a pure gas in such a way between the said inlet aperture and focusing lens in focusing region said perforated high transmission surface, or between the focusing lens said additional electrostatic means and the said perforated high transmission surface, whereby approximately all said gas passes into the said focusing region and through the said plurality of holes in said perforated high transmission surface preventing larger particles from crossing the surface of the said perforated high transmission element surface from the said source region to into the said focusing region.
- 27. (new): Method as in claim 18, wherein providing the transfer of said charged particles or ions from said highly dispersive source at or near atmospheric pressure for gas-phase ion analysis, said electrostatic field ratio at points equidistant from the upstream of said topside and downstream of said underside surface of said high transmission surface is greater than 1 to 1 with said downstream (focusing side) having the greater magnitude.